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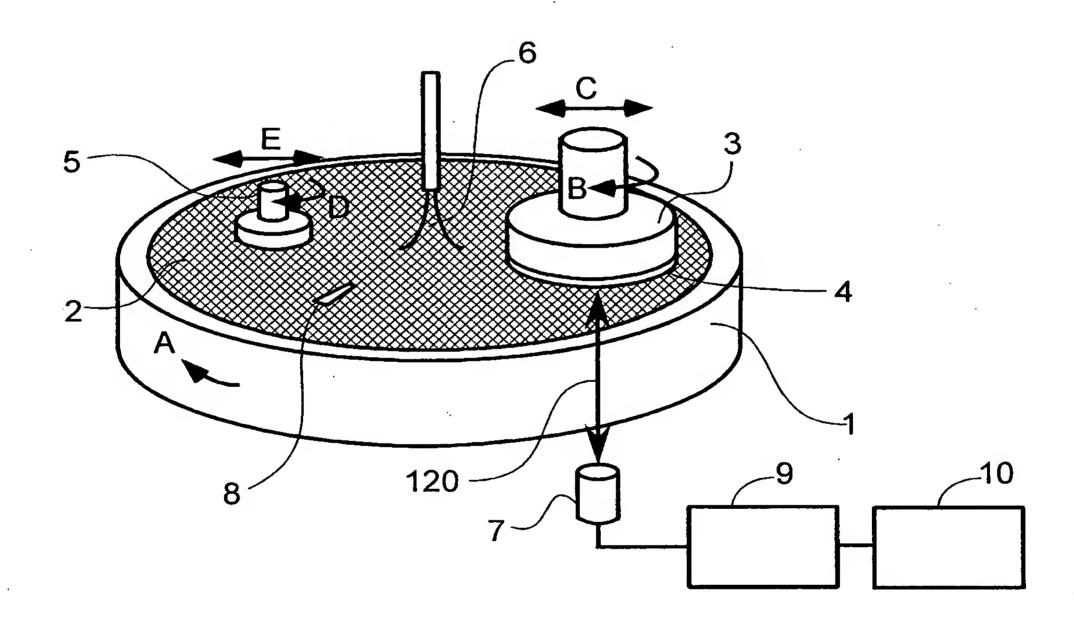
Mineo NOMOTO, *et al.*Application No. 10/082,520

"Method and Apparatus for Measuring Thickness of Thin Film and Device Manufacturing Method Using Same"

Attorney Docket No. 16869P-041600US

Robert C. Colwell, Reg. No. 27,431

(650) 326-2400



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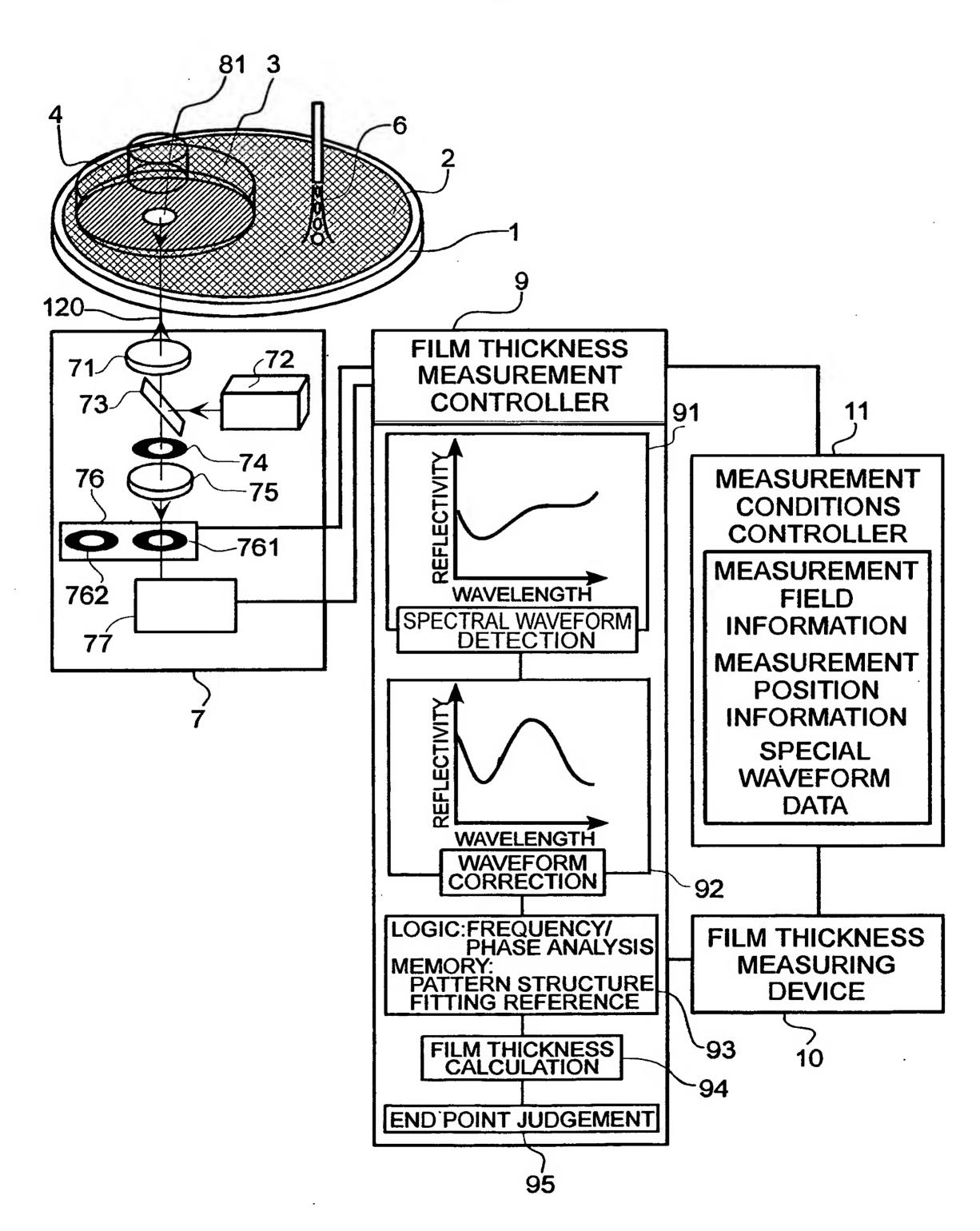
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"Method and Apparatus for Measuring Thickness of Thin Film and Device Manufacturing Method Using Same"

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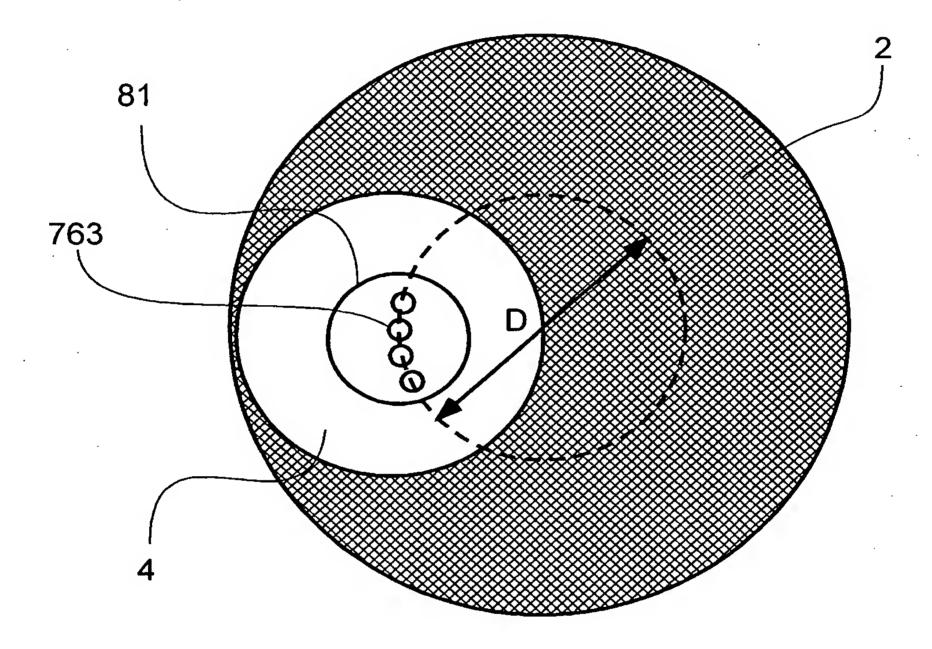
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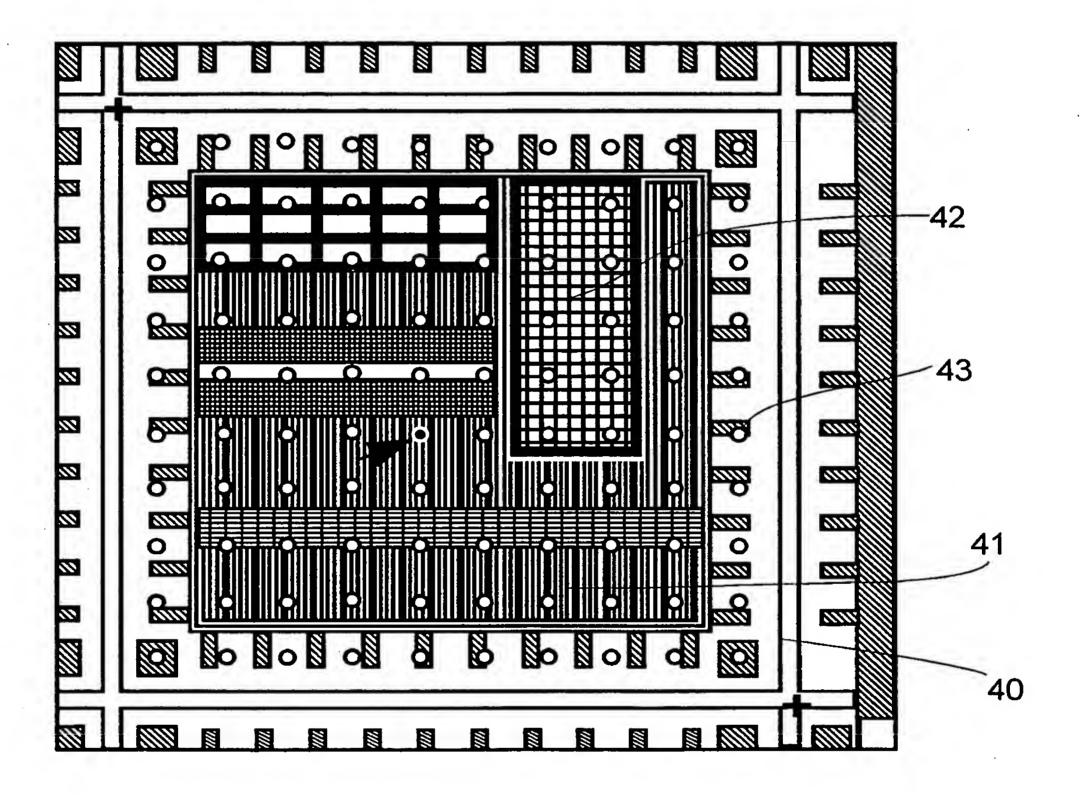
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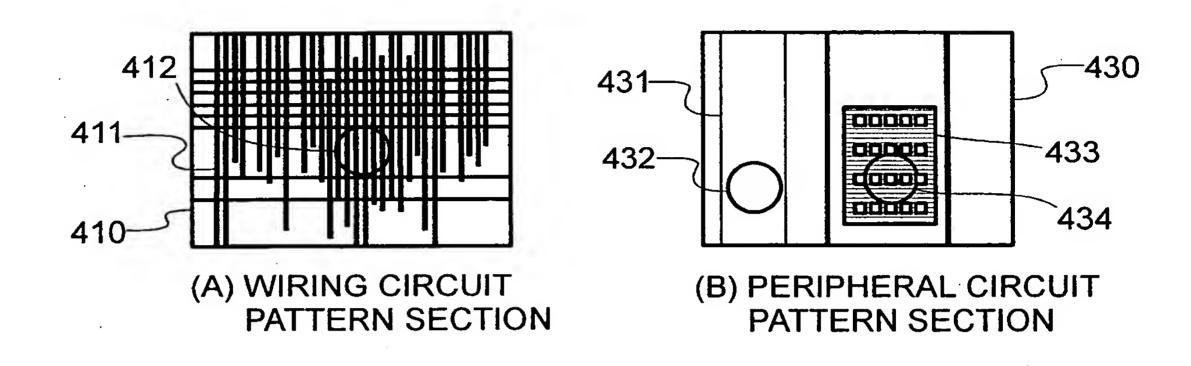
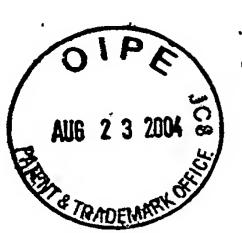


FIG.6

63
600
61

400
500
600
700
800
WAVELENGTH (nm)



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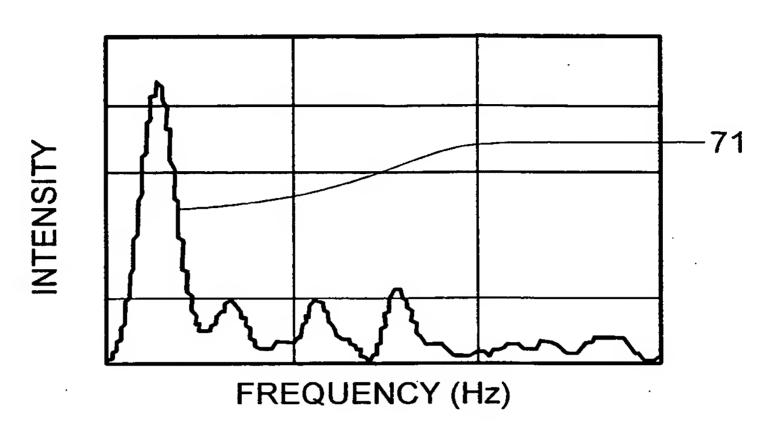
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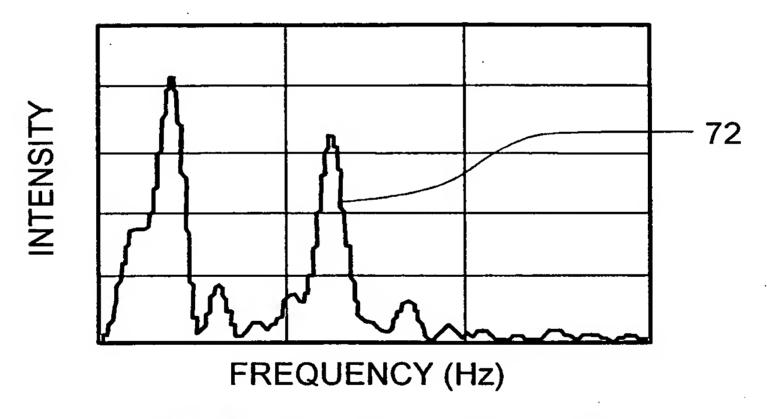
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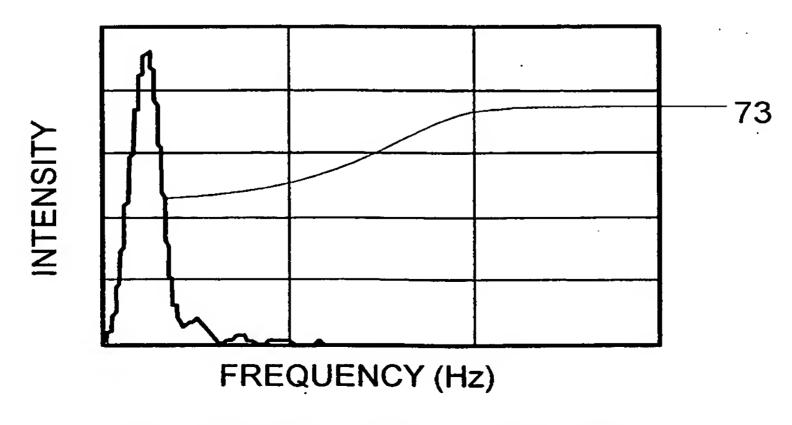
FIG.7



(a) WIRING CIRCUIT SECTION



(b) MEMORY CIRCUIT SECTION



(c) PERIPHERAL CIRCUIT SECTION

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FIG.8

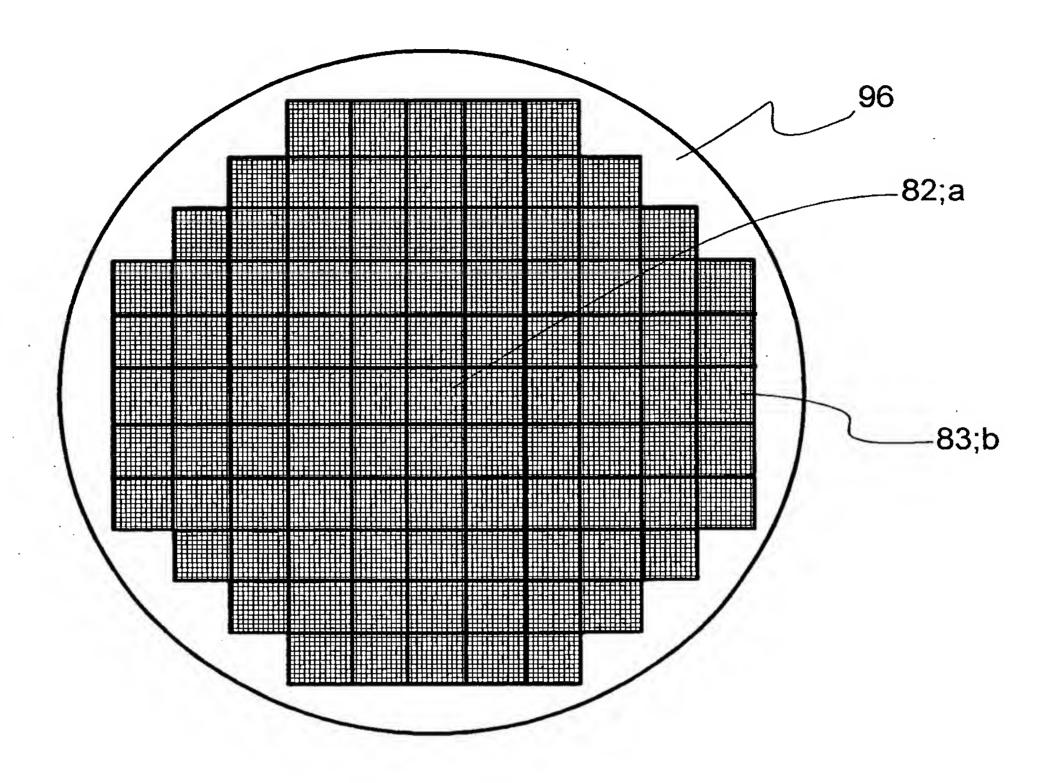
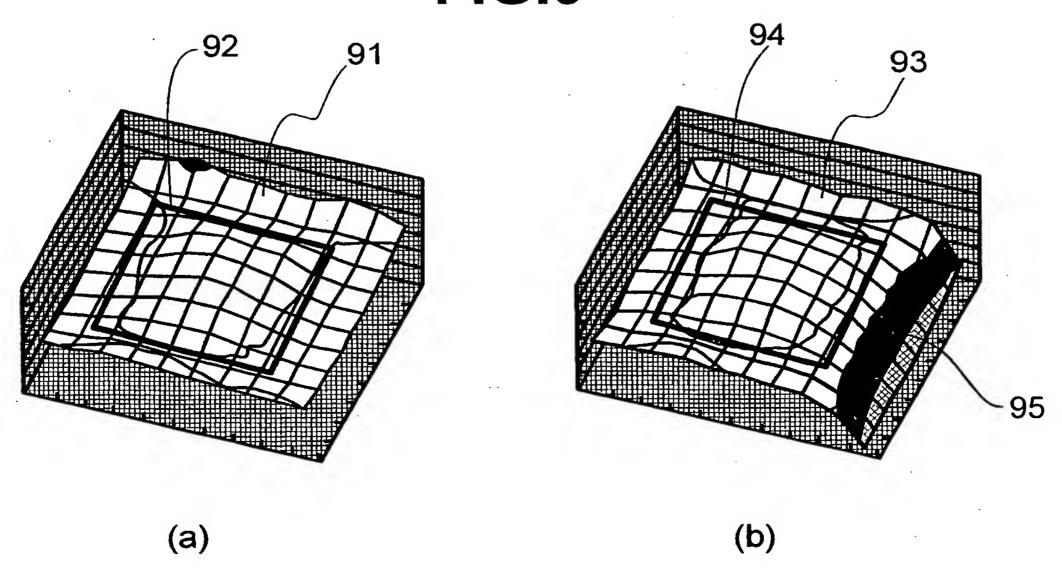


FIG.9





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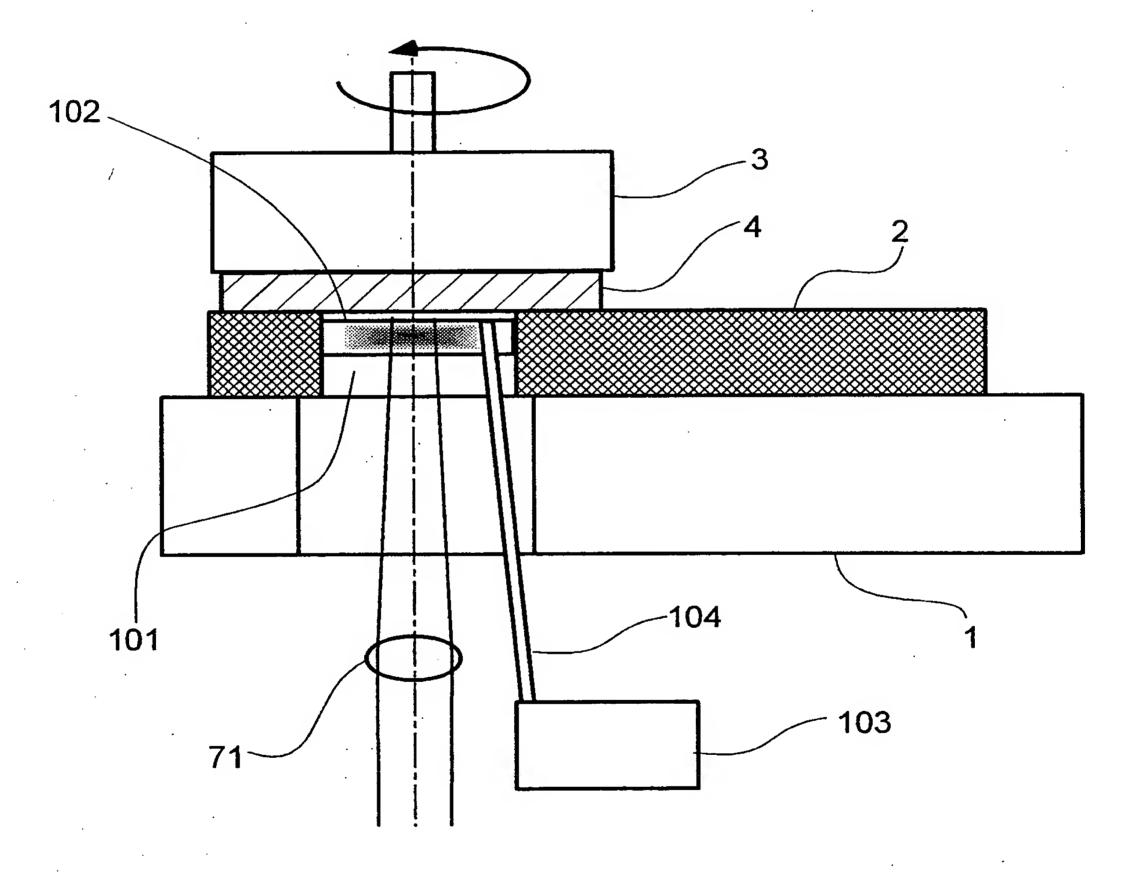
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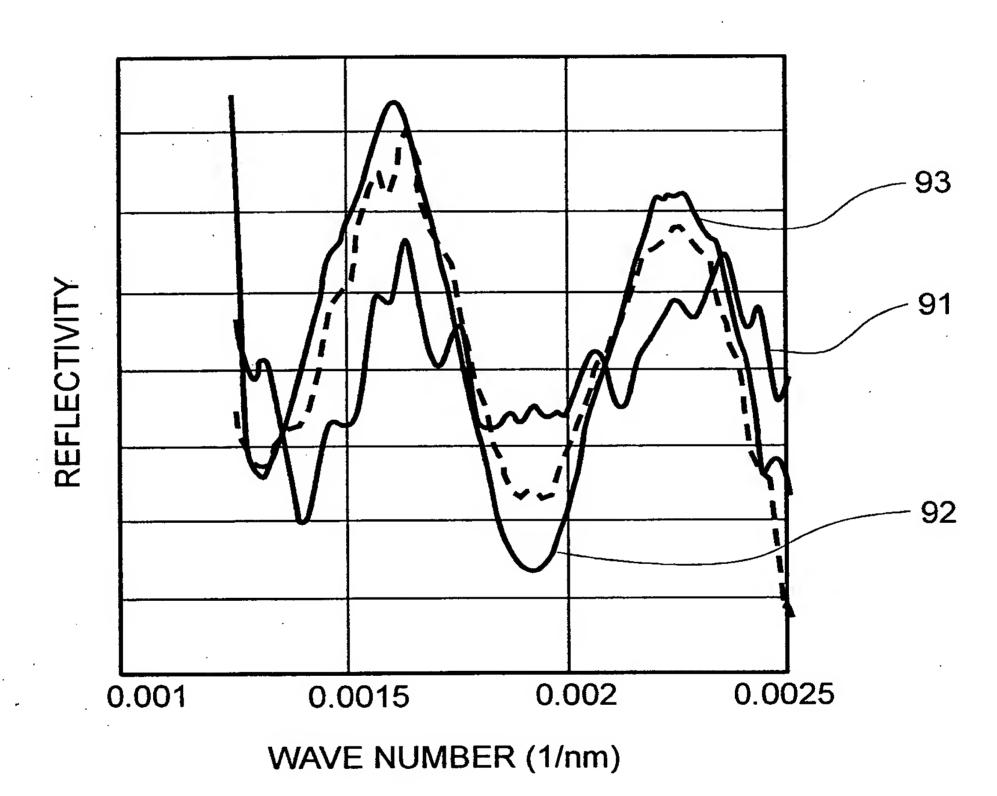
FIG.10





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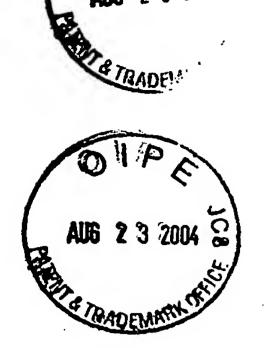
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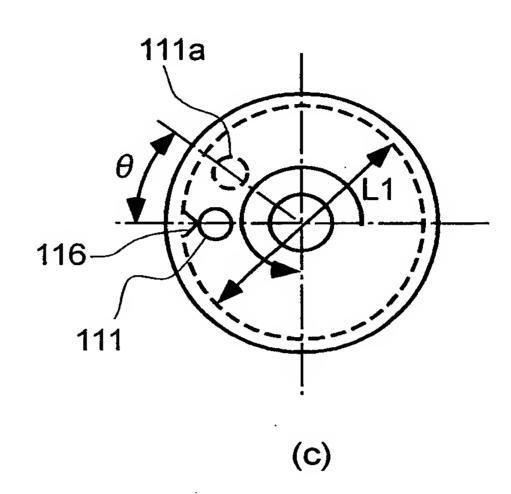
Application No. 10/082,520

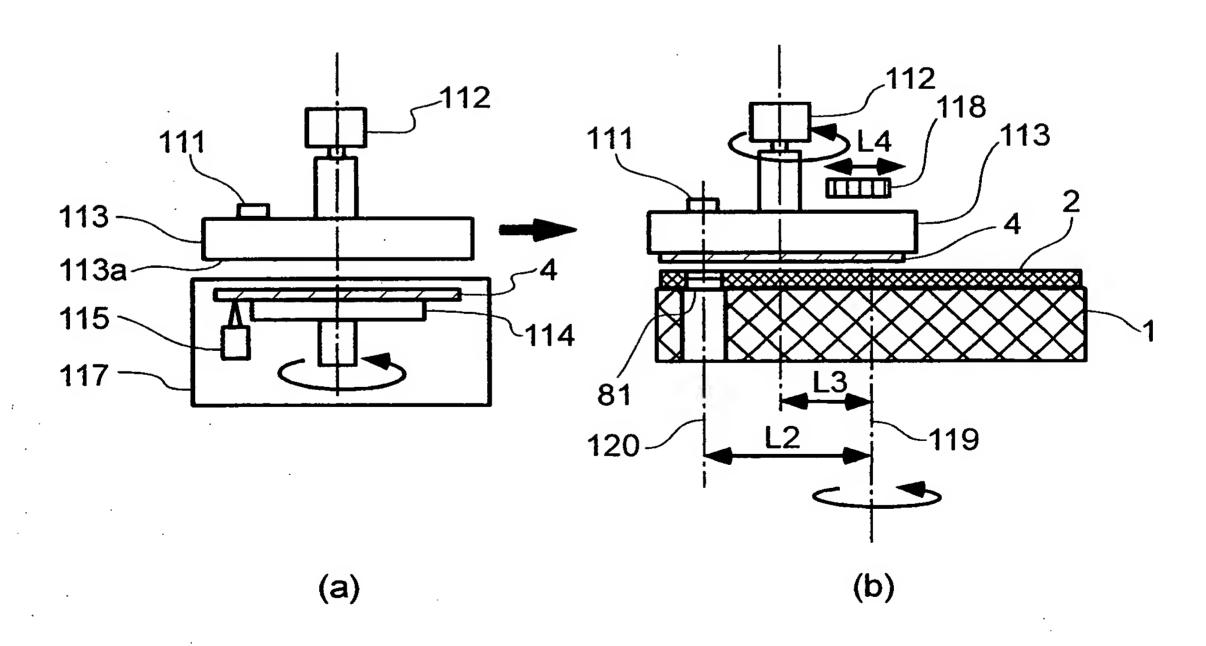
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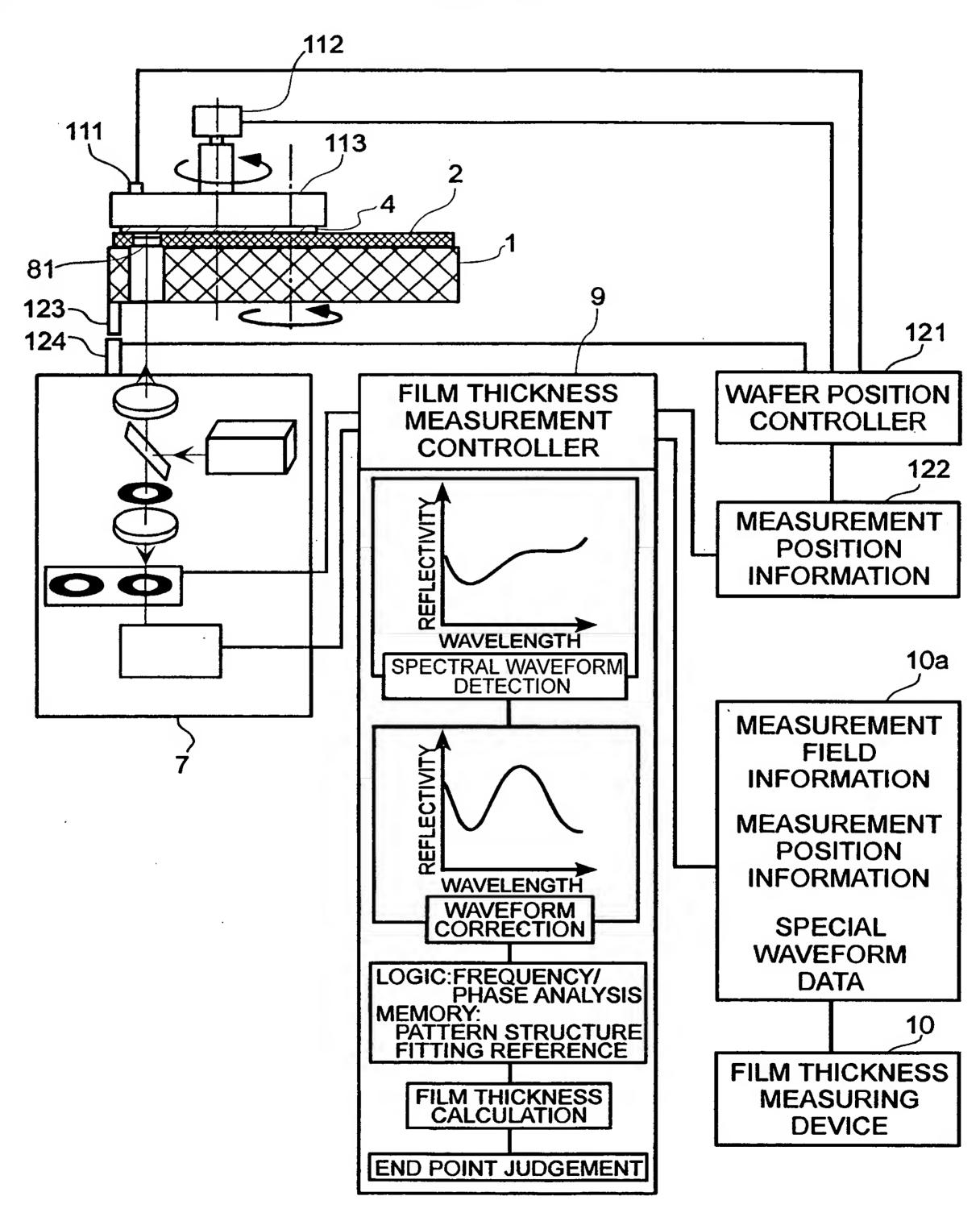
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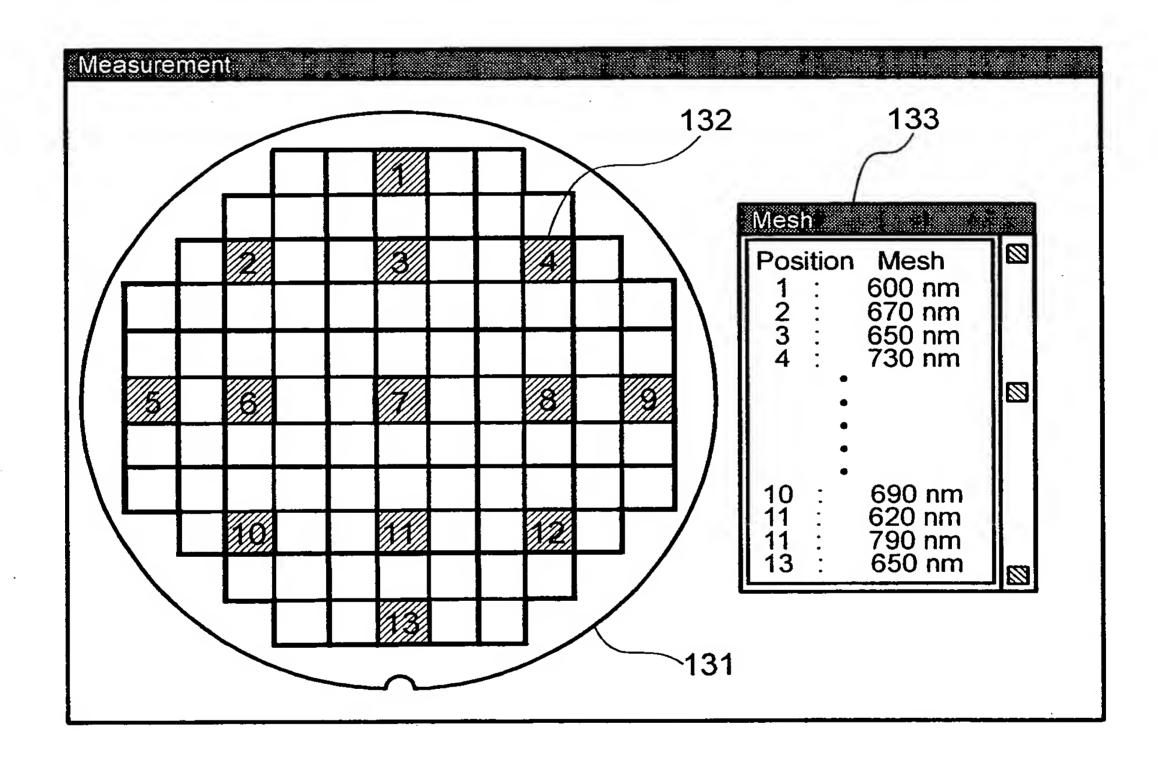
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FIG.14



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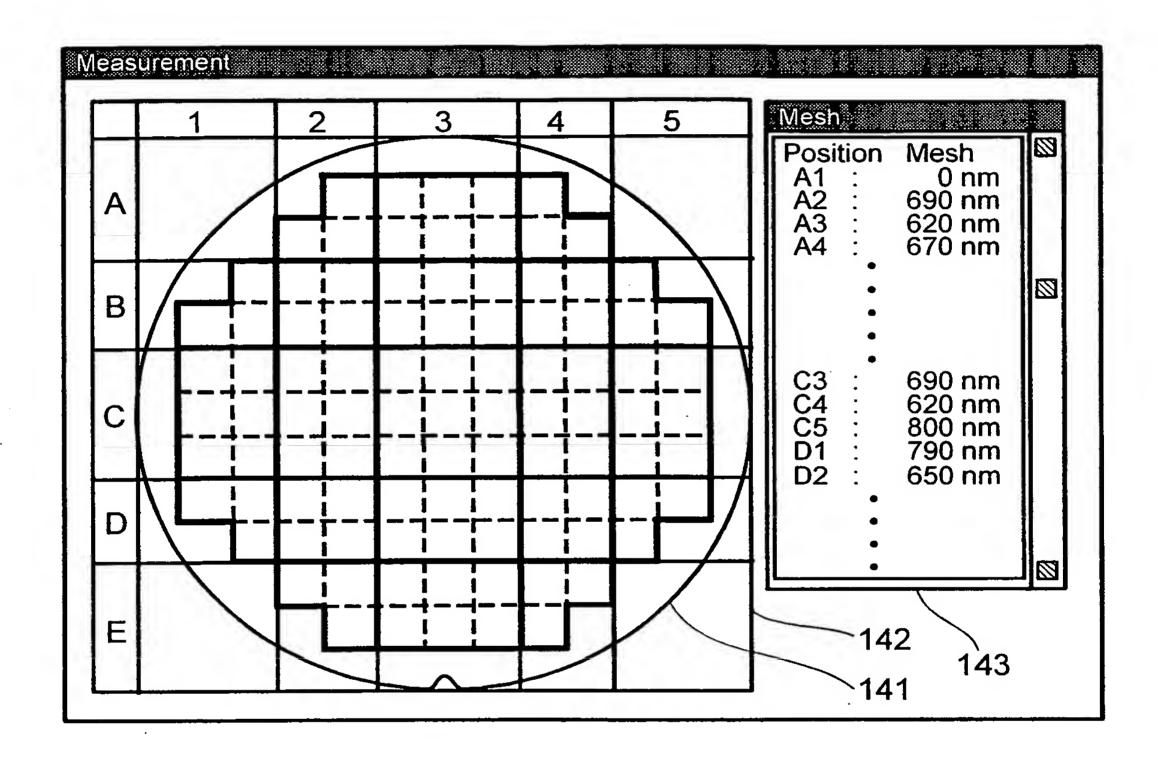
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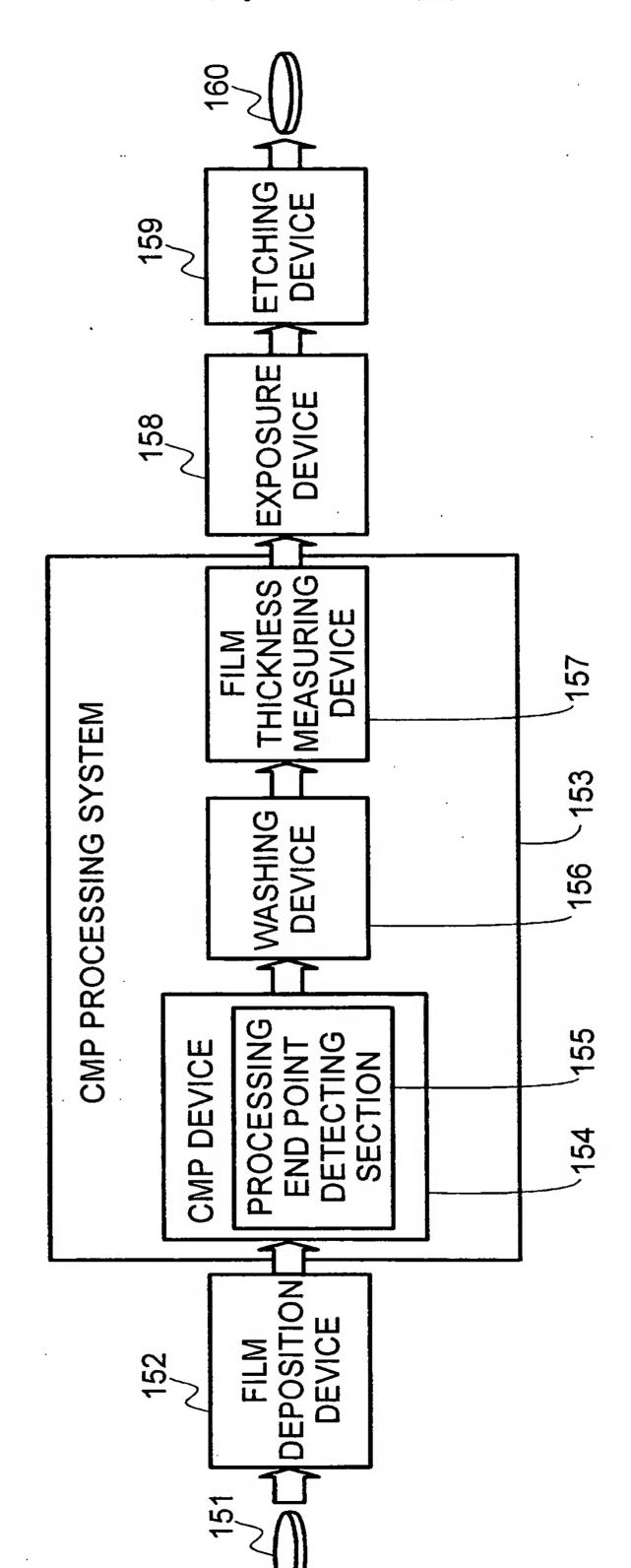
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